TEST LOG



Article number: 300742WS005		Sprache Language	DE OEN OFR	ONL OES OP
Internal number:	Serial numb	er:	Date:	09.10.2023
Device status:		Bemerkungen / Remarks:		
As good as new unused				
Damaged (light) technically inspected				
Damaged (dents/scratches) technically check	ked			
Signs of wear (light) technically checked				
Traces of use technically checked				
Product Specific Information				
VDE test conducted:	S \square	NO	NOT NECESSARY	
Device complete:	S \square	NO		
All functions tested:	S \square	NO		
Device cleaned:	s 🔲	NO		
Packaging:				
Original packaging				
Original packaging (damaged)				

Picture 1

Substitute packaging





Picture 2



Picture 3





Picture 4



Picture 5



Picture 6

